Serial No. 10/670,824
Applicant: Brokenshir

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

Applicant: Brokenshire Filing Date: 9/25/2003

Group:

Atty. Docket No. <u>AUS920030702US1</u>

			U.S. PATENT	DOCUMENTS		
Examiner <u>Initial</u>		Document Number	<u>Date</u>	<u>Name</u>	Classification Class / Subclass	Filing Date i
	AA				•	
	AB					
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			FOREIGN PATE	NT DOCUMENTS		
Examiner		Document	.	.	aá	Translation
<u>Initial</u>		Number	<u>Date</u>	Country	Classification	Yes No
PN	AH	JP2002-366534	12-2002	Japan	G06F 15/177	abstract only
PN	ΑI	JP05-242057	09-1993	Japan	G06F 15/16	abstract only
PN	ΑJ	JP10-269165	10-1998	Japan	G06F 13/16	abstract only
PN	AK	JP08-095757	04-1996	Japan	G06F 9/06	abstract only
PN	AL	JP2002-342165	11-2002	Japan	G06F 12/14	abstract only
PN	AM	JP2003-140912	05-2003	Japan	G06F 9/54	abstract only
PN	AN	JP08-147171	06-1996	Japan	G06F 9/445	abstract only
PN	AO	ЈР06-044110	02-1994	Japan	G06F 12/00	abstract only

Examiner OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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Examiner: /Phillip Nguyen/ Date Considered:

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

02/09/2007

Serial No. 10/670,824

FOR

Applicant: Brokenshire, et. al.

Filing Date: 9/25/2003

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Atty. Docket No. AUS920030702US1

LIST OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION DISCLOSURE
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STATEMENT

U. S. PATENT DOCUMENTS

Examiner <u>Initial</u>		Document Number	<u>Date</u>	Name	Classification Class / Subclass	Filing Date if Appropriate
PN	AA	4,787,057	11-1998	Hammond	708/607	
PN	AB	5,548,798	08-1996	King	710/68	
-	AC					
	AD					

FOREIGN PATENT DOCUMENTS

Examiner <u>Initial</u> Document Number

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Classification

Translation Yes No

Examiner <u>Initial</u> OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner:

/Phillip Nguyen/

Date Considered:

02/09/2007

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LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE **STATEMENT**

U. S. PATENT DOCUMENTS

Examiner <u>Initial</u>		Document <u>Number</u>	<u>Date</u>	<u>Name</u>	Classification Class / Subclass	Filing Date if Appropriate	
PN_	AA	2003/0074650	04-2003	Akgul et al.	717/129		
PN	AB	6,480,818	11-2002	Alverson et al.	703/26		

FOREIGN PATENT DOCUMENTS

Examiner **Initial**

Document Number

Date

Country

Classification

Translation Yes No

Examiner <u>Initial</u>

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner:

/Phillip Nguyen/

Date Considered:

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Serial No. 10/670,824

Applicant: <u>Brokenshire</u>, et. al. Filing Date: 9/25/2003

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LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

Group:

Atty. Docket No. AUS920030702US1

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Examiner <u>Initial</u>		Document Number	<u>Date</u>	Classification Name Class / Subclass		Filing Date if Appropriate	
PN	AA	5,887,186	03-1999	Nakanishi	712/28		
PN	AB	5,490,278	02-1996	Mochizuki	708/446		

FOREIGN PATENT DOCUMENTS

Examiner Initial

Document Number

Date

Country

Classification

Translation Yes_No

Examiner Initial OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner:

/Phillip Nguyen/

Date Considered:

02/09/2007

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In Place of FORM PTO-1449 (Modified) Serial No. 10/670,824 Applicant: Brokenshire, et. al. LIST OF PATENTS AND PUBLICATIONS FOR Filing Date: 9/25/2003 Group: APPLICANT'S INFORMATION DISCLOSURE **STATEMENT** Atty. Docket No. AUS920030702US1 **U. S. PATENT DOCUMENTS** Examiner Document Classification Filing Date if <u>Initial</u> Number <u>Date</u> Name Class / Subclass **Appropriate** PN AA 6,526,491 02-2003 Suzuoki et al. 711 / 164 PN AB 6,128,724 10-2000 712/32 Lee et al. PNAC 6,381,659 04-2002 Proch et al. 710/57 AD AB AF AG AH ΑI AJ AK AL **FOREIGN PATENT DOCUMENTS Translation** Examiner Document <u>Initial</u> Number Classification Yes No <u>Date</u> Country AM AN AO AP Examiner OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) <u>lnitial</u> AQ AR AS AT AU 02/09/2007 Date Considered: Examiner: /Phillip Nguyen/ EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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In Place of	FORM	PTO-1449 (Modif	ied)	Serial No						
LIST OF F	PATEN	TS AND PUBLIC	ATIONS FOR	Filing Date:						
APPLICANT'S INFORMATION DISCLOSURE STATEMENT				Group:Atty. Docket No. A	US9200307	02US1				
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Examiner		Document					Filing Date if			
Initial		Number	<u>Date</u>	Name	Class	Subclass	Appropriate			
PN	AA	2003/0055984	Jul. 18, 2002	Shimakawa et al.	709	316	Oct. 12, 2001			
PN	AB	2002/0156993	Oct. 24, 2002	Suzuoki et al.	712	30	Mar 22, 2001			
PN	AC	2002/0138707	Sep 26, 2002	Suzuoki et al.	711	163	Mar 22, 2001			
PN	AD	2002/0138701	Sep 26, 2002	Suzuoki et al.	711	154	Mar 22, 2001			
PN	ΑE	2002/0138637	Sep 26, 2002	Suzuoki et al.	709	230	Mar 22, 2001			
PN	AF	2002/0135582	Sep 26, 2002	Suzuoki et al.	345	502	Mar 22, 2001			
PN	AG	2002/0095523	Jul. 18, 2002	Shimakawa et al.	709	316	Oct. 12, 2001			
PN	AΗ	2002/0060690	May 23, 2002	Tanaka et al.	345	619	Mar. 1, 2001			
PN	ΑI	2002/0046229	Apr. 18, 2002	Yutaka et al.	709	102	Mar. 2, 2001			
PN	ΑJ	6,559,854	May 6, 2003	Oka et al.	345	619	Mar. 1, 2001			
_PN	AK	2001/0002130	May 31, 2001	Suzuoki	345	420	Dec 15, 2000			
PN	AL	6,526,491	Feb. 25, 2003	Suzuoki et al.	711	164	Мат 22, 2001			
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